


<b>Search Notes</b>  	<b>Application/Control No.</b>  10584956	<b>Applicant(s)/Patent Under Reexamination</b>  BAKER ET AL.
	<b>Examiner</b>  DAVID Q NGUYEN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
370	312	02/18/2010	DN
375	329	02/18/2010	DN
375	279	02/18/2010	DN
375	280	02/18/2010	DN
375	260	05/27/2010	DN
375	267	05/27/2010	DN
375	264	05/27/2010	DN
375	295	05/27/2010	DN

SEARCH NOTES		
Search Notes	Date	Examiner
Text search	05/27/2010	DN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Text search		05/27/2010	DN

	/DAVID Q NGUYEN/ Primary Examiner.Art Unit 2617
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